Semiconductor Device Test Set - Page 1 of 1



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| Width: |
|--|
| 250.0 millimeters |
| Ac Voltage Rating: |
| 115.0 volts |
| Frequency Rating: |
| 60.0 hertz |
| Depth: |
| 286.0 millimeters |
| End Application: |
| Nsn 5826-00-117-7747 calibration bench mock up |
| Electrical Power Source Relationship: |
| Operating |
| Inclosure Feature: |
| Single item w/housing |
| Test Type For Which Designed: |
| In-circuit testing of components |
| Phase: |
| Single |
| Height: |
| 86.0 millimeters |
| Reference Data And Literature: |
| To 33a1-15-55-4 |
| Shelf Life: |
| N/a |
| Unit Of Measure: |
| |
| Demilitarization: |
| No |
| Fiig: |
| Т228-а |
| |